



[2345/17A]

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s) : Rainer LOESCH, et al.  
Serial No. : 09/750,837  
Filed : December 28, 2000  
Title : CALIBRATED SCALE IN THE NANOMETER RANGE FOR  
TECHNICAL DEVICES USED FOR THE HIGH-  
RESOLUTION OR ULTRAHIGH-RESOLUTION IMAGING  
OF STRUCTURES  
Art Unit : 1774  
Examiner : Lawrence Ferguson

Mail Stop AF  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

I hereby certify that this correspondence is being deposited with the  
United States Postal Service as first class mail in an envelope addressed  
to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-  
1450 on

Date: June 15, 2004

Signature: Linda M. Shudy  
Linda M. Shudy (Reg. No. 47,084)

AMENDMENT

SIR:

In response to the Office Action having mailing date December 15, 2003, please  
reconsider the above-identified application based on the following amendments and remarks.

**Amendments to the Claims** are reflected in the listing of claims, which begins on  
page 2 of this paper.

**Remarks** begin on page 3 of this paper.